

Notice of References Cited	Application/Control No. 10/530,031		Applicant(s)/Patent Under Reexamination TAKAKUWA ET AL.	
	Examiner HELEN SHIBRU		Art Unit 2621	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,453,110	09-2002	Kawamura et al.	386/46
*	B	US-2005/0031311	02-2005	Bak et al.	386/095
*	C	US-6,654,031	11-2003	Ito et al.	715/723
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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